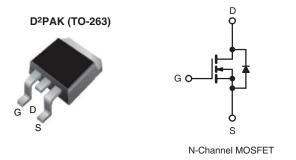
COMPLIANT

HALOGEN FREE



E Series Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V) at T _J max. 700					
R _{DS(on)} max. at 25 °C (Ω)	V _{GS} = 10 V 0.28				
Q _g max. (nC)	96				
Q _{gs} (nC)	11				
Q _{gd} (nC)	21				
Configuration	Single				



FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (C_{iss})
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

ORDERING INFORMATION			
Package	D ² PAK (TO-263)		
Lead (Pb)-free and Halogen-free	SiHB15N65E-GE3		

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V_{DS}	650	V
Gate-Source Voltage			V_{GS}	± 30	
Continuous Dusin Courset (T. 150 °C)	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	I _D	15	
Continuous Drain Current (T _J = 150 °C)		T _C = 100 °C		10	Α
Pulsed Drain Current ^a			I _{DM}	38	
Linear Derating Factor				1.4	W/°C
Single Pulse Avalanche Energy b			E _{AS}	286	mJ
Maximum Power Dissipation			P_{D}	34	W
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C
Drain-Source Voltage Slope T _J = 125 °C			dV/dt	37	\//na
Reverse Diode dV/dt ^d				23	- V/ns
Soldering Recommendations (Peak Temperature) c for 10 s				300	°C

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 28.2 \,^{\circ}\text{mH}$, $R_q = 25 \,^{\circ}\Omega$, $I_{AS} = 4.5 \,^{\circ}\text{A}$.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, dl/dt = 100 A/ μ s, starting $T_J = 25$ °C.

THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.7	C/ VV	

Vishay Siliconix

No. Static	SPECIFICATIONS (T _J = 25 °C, u	nless otherwi	se noted)					
Drain-Source Breakdown Voltage VDS VGS = 0 V, ID = 250 μA 650 - V VDS Temperature Coefficient ΔVDS/TJ Reference to 25 °C, ID = 1 mA - 0.75 - VPC Cate-Source Threshold Voltage (N) VGS(m) VDS = VGS, ID = 250 μA 2 - 4 V VDS = 20 V VGS = 20 V - - ±100 NA VDS = 20 V VGS = 20 V - - ±100 NA VDS = 20 V VGS = 20 V - - ±100 NA VDS = 520 V, VGS = 0 V - - ±1 μA VDS = 650 V, VGS = 0 V - - ±1 μA VDS = 650 V, VGS = 0 V - - ±1 μA VDS = 650 V, VGS = 0 V - - ±1 μA VDS = 650 V, VGS = 0 V - - ±1 μA VDS = 520 V, VGS = 0 V - - ±1 μA VDS = 520 V, VGS = 0 V - - ±1 μA VDS = 520 V, VGS = 0 V - - ±1 μA VDS = 520 V, VGS = 0 V - - ±1 μA VDS = 520 V, VGS = 0 V - - ±1 μA VDS = 520 V, VGS = 0 V - - ±1 μA VDS = 520 V, VGS = 0 V - - ±1 μA VDS = 520 V, VGS = 0 V - - ±1 μA - ±1 μA VDS = 520 V, VGS = 0 V - - ±1 μA	PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Vos Temperature Coefficient	Static							
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	650	-	-	V
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.75	-	V/°C
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2	-	4	V
Vos = 430 V -		_		$V_{GS} = \pm 20 \text{ V}$		-	± 100	nA
Parin-Source On-State Resistance Pass Vas = 520 V, Vas = 0 V, Ty = 125 °C 10 Parin-Source On-State Resistance Pass Vas = 10 V Ia = 8 A - 0.23 0.28 Ω	Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 V	-	-	± 1	μA
Parin-Source On-State Resistance Pass Vas = 520 V, Vas = 0 V, Ty = 125 °C 10 Parin-Source On-State Resistance Pass Vas = 10 V Ia = 8 A - 0.23 0.28 Ω			V _{DS} =	= 650 V, V _{GS} = 0 V	-	-	1	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Zero Gate Voltage Drain Current	I _{DSS}			-	-	10	μA
Forward Transconductance gfs V _{DS} = 30 V, I _D = 8 A - 5.6 - S	Drain-Source On-State Resistance	R _{DS(on)}			-	0.23	0.28	Ω
$ \begin{array}{ c c c c c c } \hline \mbox{lnput Capacitance} & C_{iss} & V_{GS} = 0 \ V, \\ \hline \mbox{Output Capacitance} & C_{oss} & V_{OS} = 100 \ V, \\ \hline \mbox{Reverse Transfer Capacitance} & C_{rss} & V_{DS} = 100 \ V, \\ \hline \mbox{Reverse Transfer Capacitance, Energy} & C_{o(er)} & V_{DS} = 0 \ V \ to 520 \ V, V_{GS} = 0 \ V \\ \hline \mbox{Effective Output Capacitance, Energy} & C_{o(er)} & V_{DS} = 0 \ V \ to 520 \ V, V_{GS} = 0 \ V \\ \hline \mbox{Effective Output Capacitance, Time} & C_{o(tr)} & V_{DS} = 10 \ V \\ \hline \mbox{Effective Output Capacitance, Time} & Q_g & & & & & & & & & & & & & & & & & & &$	Forward Transconductance		V _{DS}	_s = 30 V, I _D = 8 A	-	5.6	-	S
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Dynamic		<u>'</u>					
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Input Capacitance	C _{iss}		Voc = 0 V	-	1640	-	
Feverse Translet Capacitance C_{rss} C_{coler} C	Output Capacitance		1		-	80	-	1
File Co(er) File F	Reverse Transfer Capacitance	C _{rss}			-	4	-	pF
		C _{o(er)}	V _{DS} = 0 V to 520 V, V _{GS} = 0 V		-	63	-	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		$C_{o(tr)}$			-	213	-	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Total Gate Charge	Qg			-	48	96	
	Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 8 A, V_{DS} = 520 V$	-	11	-	nC
Rise Time t_r $V_{DD} = 520 \text{ V}, \ l_D = 8 \text{ A}, \ V_{GS} = 10 \text{ V}, \ R_g = 9.1 \ \Omega$ $t_g = 9.1 \ \Omega$	Gate-Drain Charge	Q _{gd}	1		-	21	-	
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	t _{d(on)}			-	18	36	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time	t _r	V _{DD}	= 520 V. In = 8 A.	-	24	48	200
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-Off Delay Time	t _{d(off)}	V _{GS} :	= 10 V, $R_g = 9.1 \Omega$	-	48	96	TIS
	Fall Time	t _f			-	25	50	
Continuous Source-Drain Diode Current Is $\frac{\text{MOSFET symbol}}{\text{showing the}}$ $\frac{\text{Integral reverse}}{\text{Integral reverse}}$ $\frac{\text{Integral reverse}}{Integra$	Gate Input Resistance	R_g	f = 1 MHz, open drain		-	0.8	-	Ω
Pulsed Diode Forward Current S	Drain-Source Body Diode Characteristic	s						
Pulsed Diode Forward Current I_{SM} p - n junction diode p - n junction diode p -	Continuous Source-Drain Diode Current	IS	showing the integral reverse		-	-	15	_
Reverse Recovery Time t_{rr} $T_J = 25 ^{\circ}\text{C}$, $I_F = I_S = 8 \text{A}$, $I_S = 4.6 ^{\circ}\text{C}$ $I_S = 4.6 ^{\circ}\text{C}$	Pulsed Diode Forward Current	I _{SM}			-	-	38] A
Reverse Recovery Charge Q_{rr} $T_J = 25$ °C, $I_F = I_S = 8$ A, $dI/dt = 100$ A/ μ s, $V_R = 400$ V -4.6 $-\mu$ C	Diode Forward Voltage	V_{SD}	T _J = 25 °C, I _S = 8 A, V _{GS} = 0 V		-	-	1.2	V
Reverse Recovery Charge Q_{rr} $dI/dt = 100 \text{ A/µs}, V_R = 400 \text{ V}$	Reverse Recovery Time	t _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = I_S = 8 \text{A},$		-	325	-	ns
u/ut = 100 A/µs, V _R = 400 V	Reverse Recovery Charge	Q _{rr}			_	4.6	-	μC
	Reverse Recovery Current	I _{RRM}			-	20	-	A

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

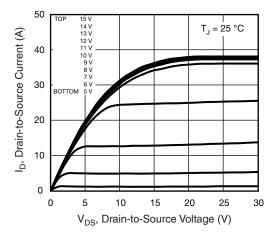


Fig. 1 - Typical Output Characteristics

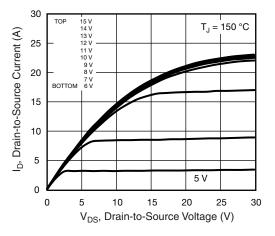


Fig. 2 - Typical Output Characteristics

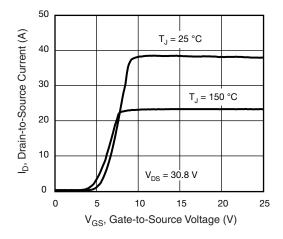


Fig. 3 - Typical Transfer Characteristics

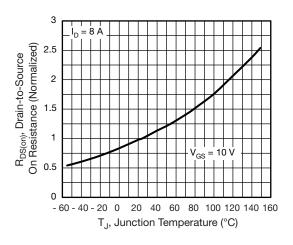


Fig. 4 - Normalized On-Resistance vs. Temperature

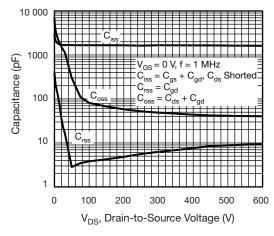


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

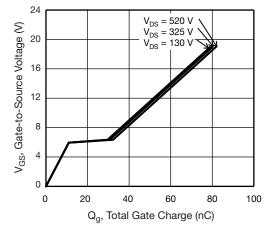


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



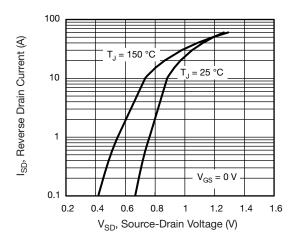


Fig. 7 - Typical Source-Drain Diode Forward Voltage

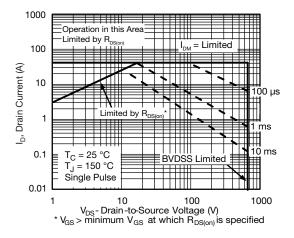


Fig. 8 - Maximum Safe Operating Area

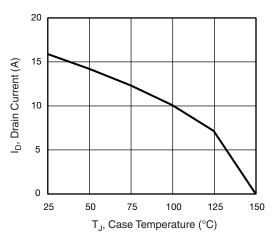


Fig. 9 - Maximum Drain Current vs. Case Temperature

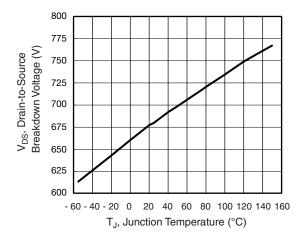


Fig. 10 - Temperature vs. Drain-to-Source Voltage

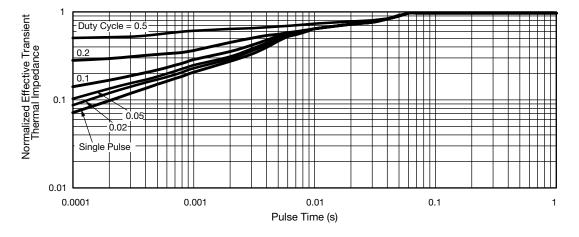


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case

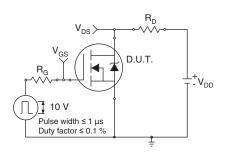


Fig. 12 - Switching Time Test Circuit

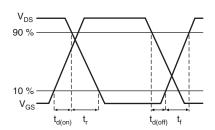


Fig. 13 - Switching Time Waveforms

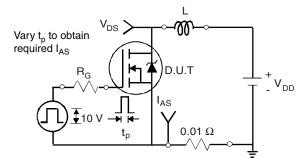


Fig. 14 - Unclamped Inductive Test Circuit

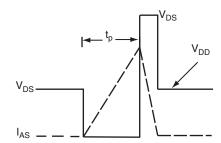


Fig. 15 - Unclamped Inductive Waveforms

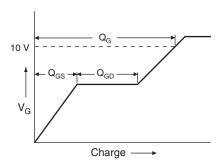


Fig. 16 - Basic Gate Charge Waveform

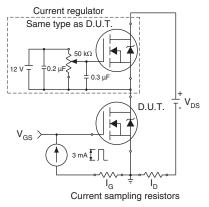
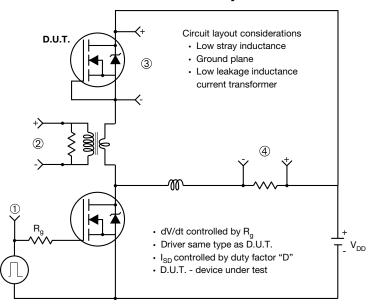


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



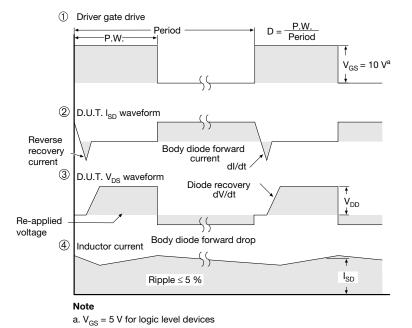


Fig. 18 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91536.





TO-263AB (HIGH VOLTAGE)







View A - A

	MILLIN	METERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIMETERS		INCHES	
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
Е	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	i
е	2.54 BSC		0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	ı	0.066
L2	-	1.78	-	0.070
L3	0.25 BSC		0.010 BSC	
L4	4.78	5.28	0.188	0.208

ECN: S-82110-Rev. A, 15-Sep-08

DWG: 5970

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

Document Number: 91364 www.vishay.com Revision: 15-Sep-08





RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)

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